Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/732,952	CHEN ET AL.		
Examiner	Art Unit		
Albert W. Paladini	2125		

	SEARCHED		
Class	Subclass	Date	Examiner
703	14,15	7/28/2006	AWP
716	4,5	7/28/2006	AWP
716	18	7/28/2006	AWP
	-		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			•

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
PLUS		7/28/2006	AWP	
EAST		7/28/2006	AWP	